

Features

Type	V _{DSS}	R _{DS(on)} max	R _{DS(on)} *Q _g	P _{TOT}
STK40N2LLH5	25V	<0.0017Ω	61.2nC*mΩ	5.2W

- Ultra low top and bottom junction to case thermal resistance
- Extremely low on-resistance R_{DS(on)}
- R_{DS(on)}*Q_g industry benchmark
- High avalanche ruggedness
- Fully encapsulated die
- 100% Matte tin finish (in compliance with the 2002/95/EC european directive)
- PolarPAK® is a trademark of VISHAY

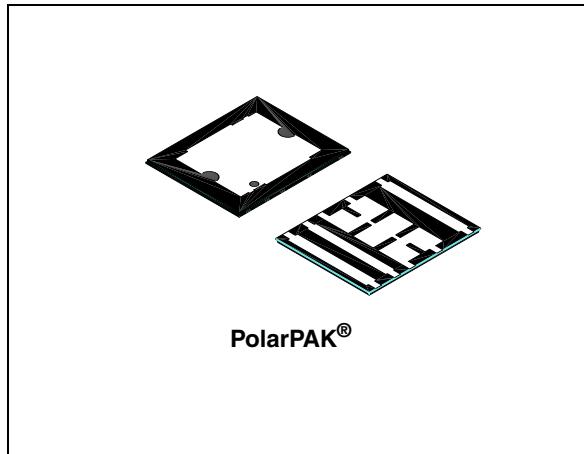


Figure 1. Internal schematic diagram

Application

- Switching applications

Description

This product utilizes the 5th generation of design rules of ST's proprietary STripFET™ technology. The lowest available R_{DS(on)}*Q_g, in this chip scale package, makes this device suitable for the most demanding DC-DC converter applications, where high power density is to be achieved.

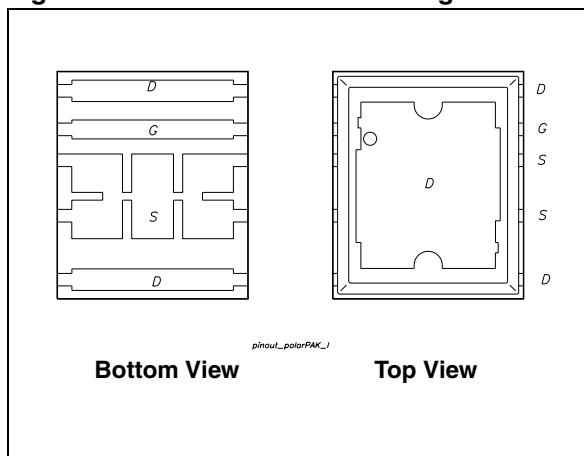


Table 1. Device summary

Order code	Marking	Package	Packaging
STK40N2LLH5	402L5	PolarPAK®	Tape and reel

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage ($V_{GS} = 0$)	25	V
V_{GS}	Gate-source voltage	± 20	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	40	A
I_D	Drain current (continuous) at $T_C = 100^\circ\text{C}$	25	A
$I_{DM}^{(2)}$	Drain current (pulsed)	160	A
$P_{TOT}^{(1)}$	Total dissipation at $T_C = 25^\circ\text{C}$	5.2	W
	Derating factor	0.0416	W/ $^\circ\text{C}$
$E_{AS}^{(3)}$	Single pulse avalanche energy	TBD	J
T_J T_{stg}	Operating junction temperature Storage temperature	-55 to 150	$^\circ\text{C}$

1. When mounted on FR-4 board of 1inch², 2 oz. Cu. and $\leq 10\text{sec}$
2. Pulse width limited by package
3. Starting $T_J = 25^\circ\text{C}$, $I_D = 20\text{ A}$, $V_{DD} = 25\text{ V}$

Table 3. Thermal data

Symbol	Parameter	Typ.	Max.	Unit
$R_{thj-amb}^{(1)}$	Thermal resistance junction-amb	20	24	$^\circ\text{C/W}$
$R_{thj-c}^{(2)}$	Thermal resistance junction-case (top drain)	0.8	1	$^\circ\text{C/W}$
$R_{thj-c}^{(3)}$	Thermal resistance junction-case (source)	2.2	2.7	$^\circ\text{C/W}$

1. When mounted on FR-4 board of 1inch², 2 oz. Cu. and $\leq 10\text{sec}$
2. Steady State
3. Measured at Source pin when the device is mounted on FR-4 board in steady state

2 Electrical characteristics

($T_{CASE}=25^{\circ}\text{C}$ unless otherwise specified)

Table 4. On/off

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0$	25			V
I_{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	$V_{DS} = \text{Max rating}, V_{DS} = \text{Max rating}, T_c = 125^{\circ}\text{C}$			1 10	μA μA
I_{GSS}	Gate body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 20 \text{ V}$			± 100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1		2.5	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0014 0.0018	0.0017 0.0022	Ω Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance			4617		pF
C_{oss}	Output capacitance	$V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0$		1065		pF
C_{rss}	Reverse transfer capacitance			170		pF
Q_g	Total gate charge	$V_{DD} = 15 \text{ V}, I_D = 40 \text{ A}$		34		nC
Q_{gs}	Gate-source charge	$V_{GS} = 4.5 \text{ V}$		TBD		nC
Q_{gd}	Gate-drain charge	(see Figure 3)		TBD		nC
R_G	Gate input resistance	$f = 1 \text{ MHz}$ Gate DC Bias = 0 Test signal level = 20 mV open drain		TBD		Ω

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on delay time Rise time	$V_{DD}= 15 \text{ V}$, $I_D= 20 \text{ A}$, $R_G=4.7 \Omega$, $V_{GS}=4.5 \text{ V}$ (see Figure 2)		TBD TBD		ns ns
$t_{d(off)}$ t_f	Turn-off delay time Fall time			TBD TBD		ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD} $I_{SDM}^{(1)}$	Source-drain current Source-drain current (pulsed)	$I_{SD}= 20 \text{ A}$, $V_{GS}=0$			40 160	A A
$V_{SD}^{(2)}$	Forward on voltage				1.1	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}= 40 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $V_{DD}=20 \text{ V}$, $T_J=150^\circ\text{C}$ (see Figure 7)		TBD TBD TBD		ns nC A

1. Pulse width limited by package
2. Pulsed: pulse duration = 300μs, duty cycle 1.5%

3 Test circuits

Figure 2. Switching times test circuit for resistive load

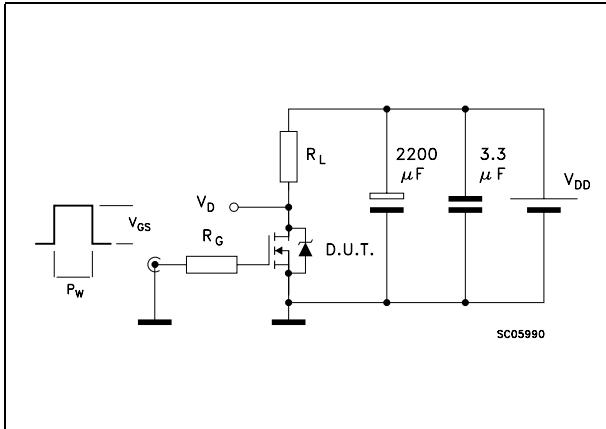


Figure 3. Gate charge test circuit

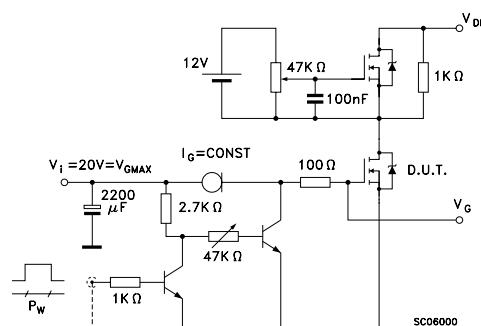


Figure 4. Test circuit for inductive load switching and diode recovery times

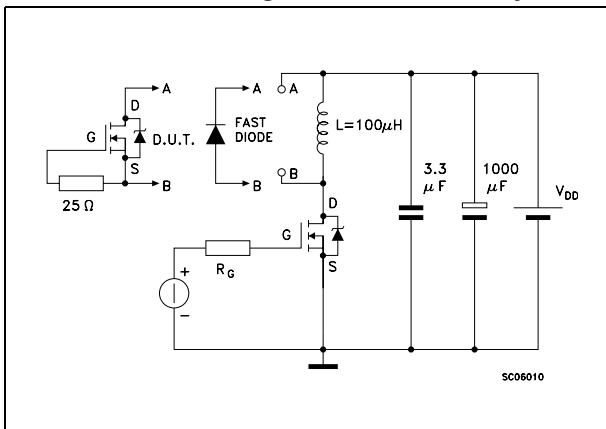


Figure 5. Unclamped inductive load test circuit

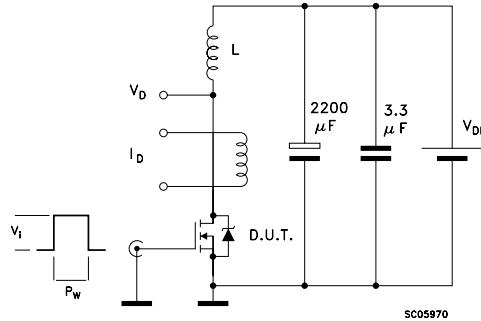


Figure 6. Unclamped inductive waveform

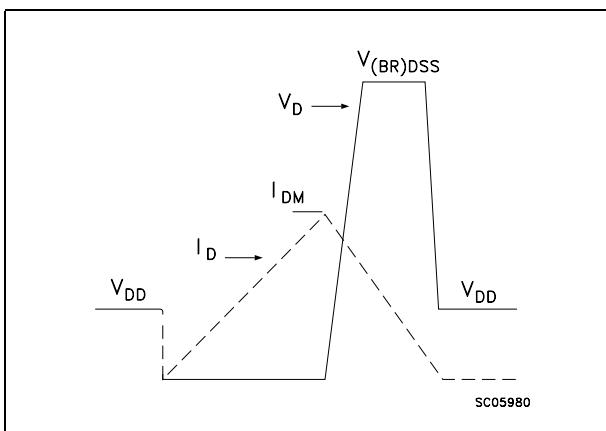


Figure 7. Switching time waveform

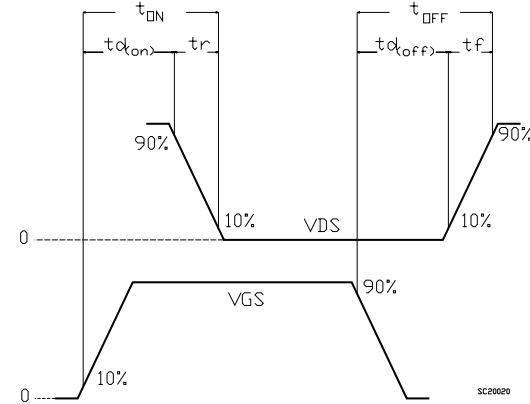
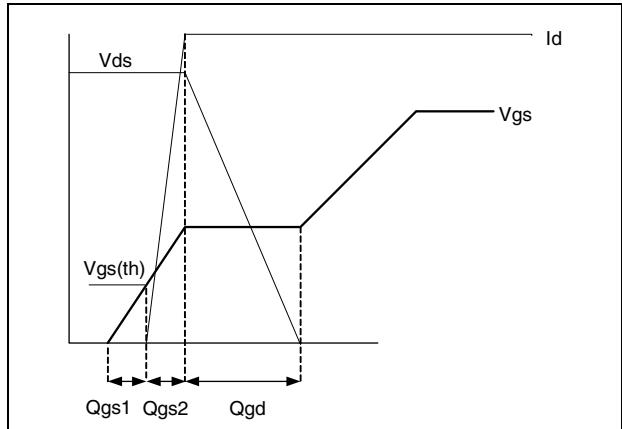


Figure 8. Gate charge waveform

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

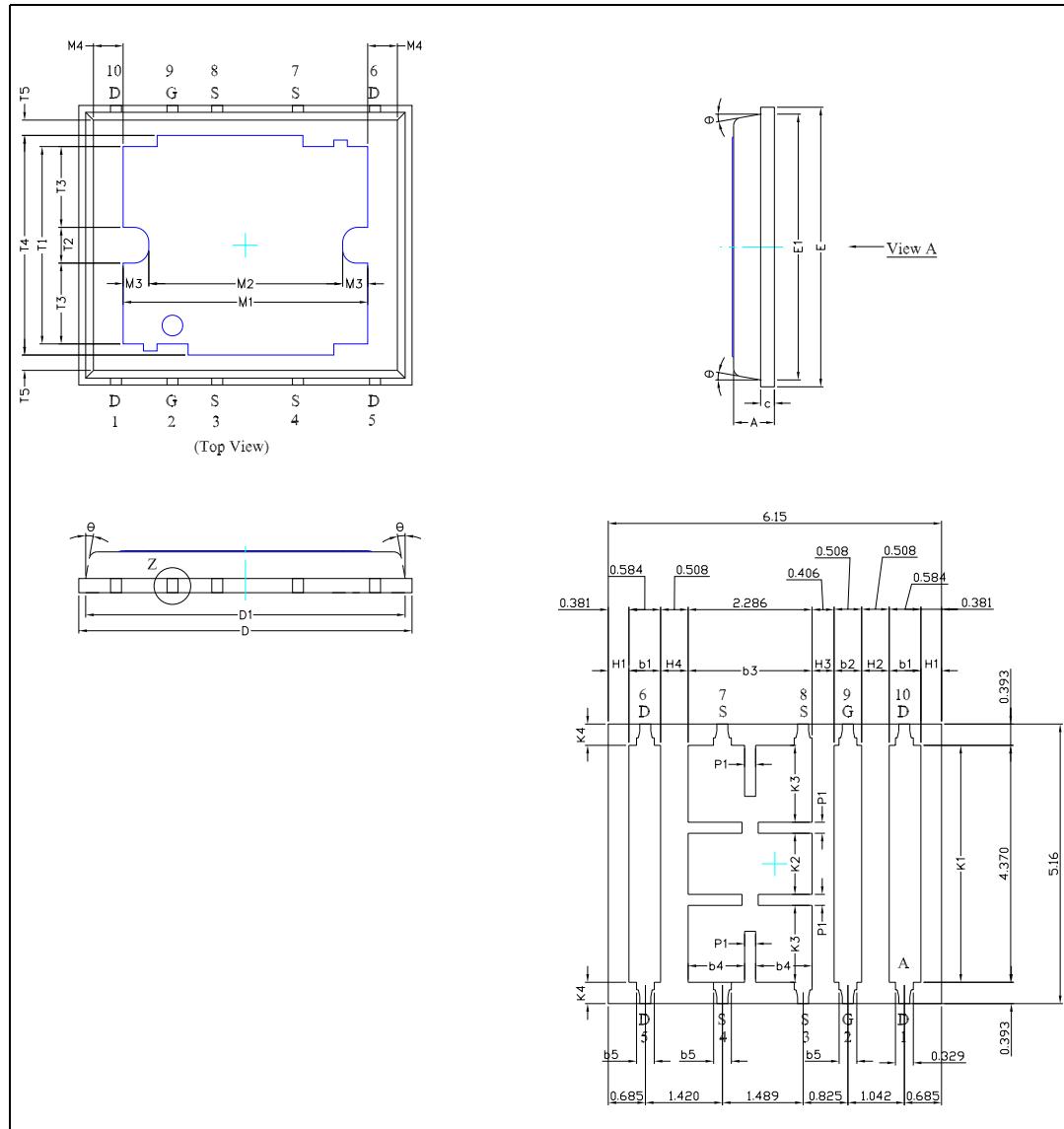
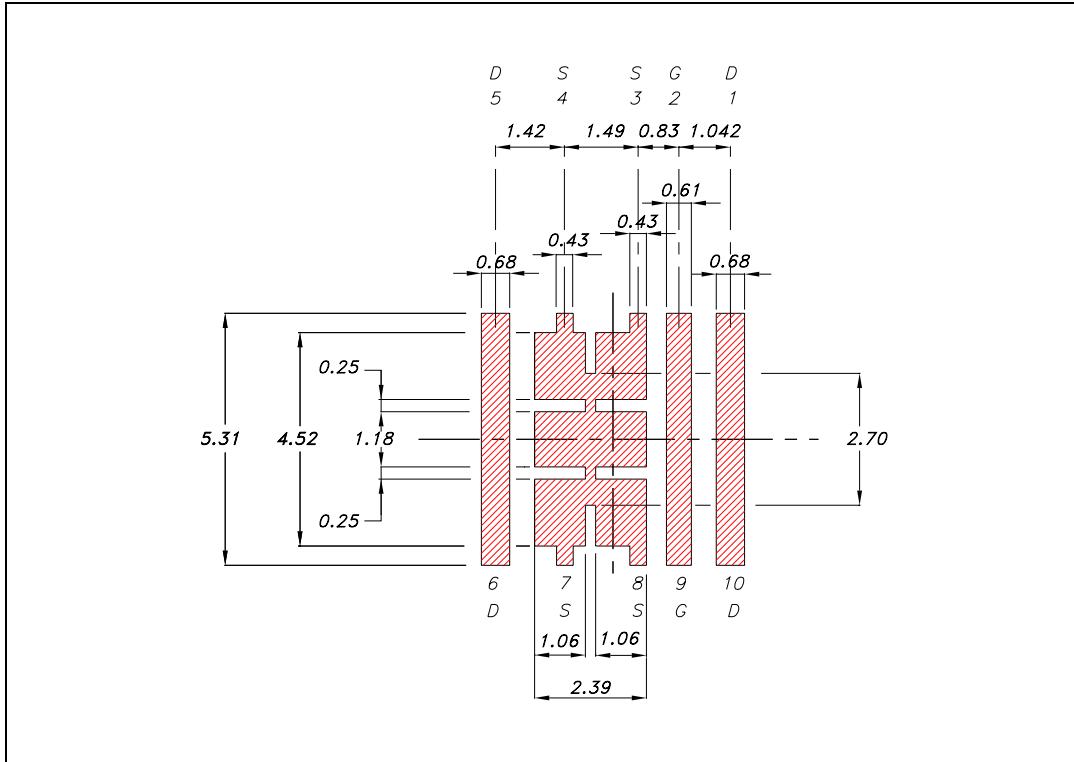
Figure 9. PolarPAK® (option “L”) drawings

Figure 10. Recommended PAD layout

5 Revision history

Table 9. Document revision history

Date	Revision	Changes
07-Jul-2008	1	First release

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